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-SHEET 1 OF 1

Form PTO 1449 (Modified)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		OF COMMERCE DEMARK OFFICE	ATTY DOCKET NO. 264681US0X PCT		SERIAL NO. 10/524,037		
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LISTOF	KEFE	RENCES CITED BY AP	PLICANT	Kai SCHUMACHER, et al.				
				FILING DATE		GROUP		
				February 9, 2005		1791		
U.S. PATENT DOCUMENTS								
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS		ILING DATE APPROPRIATE
/D.L./	AA	US 2001/0011105 A1	8-2-2001	Tetsuro NOGUCHI, et al.				
/D.L./	AB	US 6, 027,669	2-22-2000	Shirou MIURA, et al.				
	AC							
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	AN							
FOREIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	DATE	COUNTRY		TRANS YES		LATION NO
/D.L./	AO	JP 2001-326261	11-22-2001	Japan (w/English Abstract)			.,	x
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
	AW							
	AX							
	AY							
	AZ				Additional References sheet(s) attached			
Examiner	/Diana Liao/				Date Considered 09/29/2008			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								